

Designation: E668 – 05

Standard Practice for Application of Thermoluminescence-Dosimetry (TLD) Systems for Determining Absorbed Dose in Radiation-Hardness Testing of Electronic Devices¹

This standard is issued under the fixed designation E668; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ε) indicates an editorial change since the last revision or reapproval.

This standard has been approved for use by agencies of the Department of Defense.

1. Scope

1.1 This practice covers procedures for the use of thermoluminescence dosimeters (TLDs) to determine the absorbed dose in a material irradiated by ionizing radiation. Although some elements of the procedures have broader application, the specific area of concern is radiation-hardness testing of electronic devices. This practice is applicable to the measurement of absorbed dose in materials irradiated by gamma rays, X rays, and electrons of energies from 12 to 60 MeV. Specific energy limits are covered in appropriate sections describing specific applications of the procedures. The range of absorbed dose covered is approximately from 10^{-2} to 10^4 Gy (1 to 10^6 rad), and the range of absorbed dose rates is approximately from 10^{-2} to 10^{10} Gy/s (1 to 10^{12} rad/s). Absorbed dose and absorbed dose-rate measurements in materials subjected to neutron irradiation are not covered in this practice. Further, the portion of these procedures that deal with electron irradiation are primarily intended for use in parts testing. Testing of devices as a part of more massive components such as electronics boards or boxes may require techniques outside the scope of this practice.

NOTE 1—The purpose of the upper and lower limits on the energy for electron irradiation is to approach a limiting case where dosimetry is simplified. Specifically, the dosimetry methodology specified requires that the following three limiting conditions be approached: (*a*) energy loss of the primary electrons is small, (*b*) secondary electrons are largely stopped within the dosimeter, and (*c*) bremsstrahlung radiation generated by the primary electrons is largely lost.

1.2 This standard dose not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appro-

priate safety and health practices and determine the applicability of regulatory limitations prior to use.

2. Referenced Documents

- 2.1 ASTM Standards:²
- E170 Terminology Relating to Radiation Measurements and Dosimetry
- E380 Practice for Use of the International System of Units (SI) (the Modernized Metric System)
- E666 Practice for Calculating Absorbed Dose From Gamma or X Radiation
- 2.2 International Commission on Radiation Units and Measurements (ICRU) Reports:³
- ICRU Report 14—Radiation Dosimetry: X Rays and Gamma Rays with Maximum Photon Energies Between 0.6 and 50 MeV
- ICRU Report 17—Radiation Dosimetry: X Rays Generated at Potentials of 5 to 150 keV
- ICRU Report 21—Radiation Dosimetry: Electrons with Initial Energies Between 1 and 50 MeV
- ICRU Report 31—Average Energy Required to Produce an Ion Pair
- ICRU Report 33—Radiation Quantities and Units
- ICRU Report 34—The Dosimetry of Pulsed Radiation
- ICRU Report 37—Stopping Powers for Electrons and Positrons

3. Terminology

3.1 Definitions:

3.1.1 *absorbed dose,* D—the quotient of $d\bar{\epsilon}$ by dm, where $d\bar{\epsilon}$ is the mean energy imparted by ionizing radiation to the matter in a volume element and dm is the mass of matter in that volume element.

¹ This practice is under the jurisdiction of ASTM Committee E10 on Nuclear Technology and Applications and is the direct responsibility of Subcommittee E10.07 on Radiation Dosimetry for Radiation Effects on Materials and Devices on Materials and Devices.

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² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

³ Available from International Commission on Radiation Units and Measurements, 7910, Woodmont Ave., Suite 800, Bethesda, MD 20814.

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$$D = \frac{\mathrm{d}\bar{\varepsilon}}{\mathrm{d}m} \tag{1}$$

Previously, the special unit of absorbed dose was the rad; however, the gray (Gy) has been adopted as the official SI unit (see Practice E380).

$$1 \text{ Gy} = 1 \text{ J} \cdot \text{kg}^{-1} = 10^2 \text{ rad}$$
 (2)

3.1.2 *absorbed-dose rate*—the absorbed dose per unit time interval.

3.1.3 *annealing*—thermal treatment of a TLD prior to irradiation or prior to readout.

3.1.3.1 *Discussion*—Pre-irradiation annealing of TLDs is usually done to erase the effects of previous irradiation and to readjust the sensitivity of the phosphor; pre-readout annealing usually is done to reduce low-temperature TLD response.

3.1.4 *calibration conditions*—the normal environmental conditions prevailing during routine calibration irradiations such as the ambient temperature, humidity, and lighting.

3.1.5 *equilibrium absorbed dose*—the absorbed dose at some incremental volume within the material which the condition of electron equilibrium (as many electrons of a given energy enter as leave the volume) exists $(1)^4$ (see Appendix X1).

3.1.6 *exposure*, X—the quotient of dQ by dm, where dQ is the absolute value of the total charge of the ions of one sign produced in air when all the electrons (negatrons and positrons) liberated by photons in a volume element of air having mass dm are completely stopped in air.

$$X = \frac{\mathrm{d}Q}{\mathrm{d}m}$$
(3)

Unit $C \cdot kg^{-1}$

3.1.6.1 *Discussion*—Formerly the special unit of exposure was the roentgen (R).

 $1 R = 2.58 \times 10^{-1} C \cdot kg^{-1}$ (exactly)

3.1.7 primary electrons—for the case of electron irradiation, the electrons introduced into the device under test by the irradiation source.

3.1.8 secondary-electron equilibrium—for the case of electron irradiation, the condition where as many secondary electrons of a given energy enter a given volume as leave it.

3.1.9 secondary-electron equilibrium absorbed dose—for the case of electron irradiation, the absorbed dose at some incremental volume within the material in which the condition of secondary-electron equilibrium exists.

3.1.9.1 *Discussion*—Additional definitions can be found in ICRU Report 33.

3.1.10 secondary electrons—for the case of electron irradiation, electrons knocked out of the electron shells of the material being irradiated by the primary electron. For the case of photon irradiation, energetic electrons (photoelectrons, Auger electrons, and Compton electrons) produced within the material being irradiated by the action of the incident photons.

3.1.10.1 *Discussion*—Secondary electrons are produced by the interaction of the primary electrons with the atoms of the

material being irradiated. This interaction is a principal means of energy loss for the primary electrons. The kinetic energy of a secondary electron is typically much lower than that of the primary electron which creates it.

3.1.11 *test conditions*—the normal environmental conditions prevailing during routine hardness-test irradiations such as the ambient temperature, humidity, and lighting.

3.1.12 *thermoluminescence dosimeter (TLD)*—a TL phosphor, alone, or incorporated in a material, used for determining the absorbed dose in materials. For example, the TL phosphor is sometimes incorporated in a TFE-fluorocarbon matrix.

3.1.13 *thermoluminescence dosimeter (TLD) batch*—a group of TLDs, generally originating from a single mix or lot of TL phosphor, having similar TL responses and similar thermal and irradiation histories.

3.1.14 *thermoluminescence dosimeter (TLD) reader*—an instrument used to measure the light emitted from a TLD consisting essentially of a heating element, a light-measuring device, and appropriate electronics.

3.1.15 *thermoluminescence dosimeter (TLD) response*—the measured light emitted by the TLD and read out during its heating cycle consisting of one of the following: (*a*) the total light output over the entire heating cycle, (*b*) a part of that total light output, or (*c*) the peak amplitude of the light output.

3.1.16 *thermoluminescence (TL) phosphor*—a material that stores, upon irradiation, a fraction of its absorbed dose in various excited energy states. When thermally stimulated, the material emits this stored energy in the form of photons in the ultraviolet, visible, and infrared regions.

3.1.17 *TLD preparation*—the procedure of cleaning, annealing, and encapsulating the TL phosphor prior to irradiation.

3.2 For units and terminology in reports of data, Terminology E170 may be used as a guide.

4. Significance and Use 520e1117/astm-e668-05

4.1 Absorbed dose in a material is an important parameter that can be correlated with radiation effects produced in electronic components and devices that are exposed to ionizing radiation. Reasonable estimates of this parameter can be calculated if knowledge of the source radiation field (that is, energy spectrum and particle fluence) is available. Sufficiently detailed information about the radiation field is generally not available. However, measurements of absorbed dose with passive dosimeters in a radiation test facility can provide information from which the absorbed dose in a material of interest can be inferred. Under certain prescribed conditions, TLDs are quite suitable for performing such measurements.

NOTE 2—For comprehensive discussions of various dosimetry methods applicable to the radiation types and energy and absorbed dose-rate range discussed in this practice, see ICRU Reports 14, 17, 21, and 34.

5. Apparatus

5.1 The *TLD System* consists of the TLDs, the equipment used for preparation of the TLDs, and the TLD reader.

5.2 *Calibration Facility* delivers a known quantity of radiation to materials under certain prescribed environmental and geometrical conditions. Its radiation source is usually a radioactive isotope, commonly either ⁶⁰Co or ¹³⁷Cs, whose radiation

(4)

⁴ The boldface numbers in parentheses refer to the list of references at the end of this practice.

output has been calibrated by specific techniques to some specified uncertainty (usually to within ± 5 %) and is traceable to national standards.

5.3 *Storage Facility* provides an environment for the TLDs before and after irradiation, that is light tight and that has a negligible background absorbed-dose rate. A TLD stored in the facility for the longest expected storage period should absorb no more than 1 % of the lowest absorbed dose expected to be measured in hardness-testing applications.

5.4 *Environmental Chamber* is used in testing the effects of temperature and humidity on TLD response. The chamber should be capable of controlling the temperature and humidity within ± 5 % over the range expected under both calibration and test conditions.

6. Handling and Readout Procedures

6.1 Bare TLDs should not be handled with the bare fingers; dirt or grease on their surfaces can affect their response and can contaminate the heating chamber of the TLD reader. A vacuum pen or tweezers coated with TFE-fluorocarbon should be used in handling. If required, the TLDs can be cleaned by using the procedures in accordance with Appendix X2.

6.2 TLDs, especially those with high sensitivity, should be protected from light having an appreciable ultraviolet component, such as sunlight or fluorescent light. Prolonged exposure to ultraviolet light, either before or after irradiation, can cause spurious TLD response or enhanced post-irradiation fading. Incandescent lighting should be used for the TLD preparation and readout areas. However, brief exposures of a few minutes to normal room fluorescent lighting is not likely to significantly affect the TLD response except for low absorbed-dose measurements (<1 Gy or <100 rad) or measurements with high-sensitivity TLDs.

6.3 Preparation of the TLDs for irradiation consists of cleaning the TL phosphor (if required), annealing (if reusable TLDs are employed), and encapsulating the TL phosphor. Reusable TLDs require careful treatment during annealing in order to obtain the best results in dose measurements. The annealing procedure should include a reproducible temperature cycle of the annealing oven, accurate timing of the annealing period, and a reproducible cooling rate.

6.4 For low absorbed-dose measurements (<1 Gy (100 rad)), dry nitrogen should be flowed through the heating chamber of the TLD reader during readout. This suppresses the spurious TLD response that occurs in most forms of TLDs as a result of absorbed oxygen on the phosphor surface. If the TLD reader uses hot gas to heat the TLDs, nitrogen should be used.

6.5 Calibration-irradiated TLDs and all subsequent testirradiated TLDs from the same batch should be read out with the same reader using the same readout techniques and reader parameters. The calibration is valid only for that batch used in that particular reader. Readers that are different from the one used for calibration, including those of the same make and model, do not necessarily indicate the same response for TLDs irradiated to the same absorbed dose.

6.6 TLDs may be used either as reusable or as single-use dosimeters. Single-use dosimeters are irradiated once, read out, and then discarded; they are generally used as received from

the manufacturer. Dosimeters that are reused are cycled repeatedly through an anneal-irradiation-readout procedure.

6.7 The statistical methods specified in the following sections are optimal if the response of a batch of TLDs to a given radiation dose is normally distributed. However, it has been demonstrated that TLD distributions can be severely skewed, so that the sample mean may not be a suitable metric for small sample sizes (2). In this case TLDs should be fielded in groups of three, with either the lowest reading or the two extremes discarded. Whatever procedure is adopted, it must be applied consistently for all calibrations and routine measurements.

NOTE 3—Adequately determining the normality of a TLD distribution requires a large sample size.

7. Summary of Requirements for Performance Testing of a TLD System

7.1 The performance of a specific TLD system should be evaluated to determine its suitability for use in a specific radiation-hardness test. Acceptable performance of the TLD system should be verified before applying the system in a particular radiation-hardness-testing facility. Specific performance criteria will be discussed in Section 8.

7.2 Performance tests should be repeated whenever a significant change is made in the TLD system or in the specific application. Examples of such changes are: a change in the physical form or type of phosphor in the TLD, a change in any critical component or in any adjustable readout factor of the TLD reader, or a change in the irradiation source characteristics.

7.3 A particular performance test may be omitted if widely accepted documentation exists in the scientific and technical literature to show that the performance of the TLD system is satisfactory for that specific requirement. For example, if previously accepted studies document that a particular TLD has no absorbed-dose-rate dependence for the expected conditions of irradiation, then performance testing for absorbed-dose-rate dependence of that TLD system is unnecessary. All reports of test results should include appropriate references that substantiate the performance of the system and thereby justify the omission of such performance tests.

7.4 If a particular TLD system fails to meet the performance specification of any performance test, then use of that TLD system is not recommended. Such a system may be used only if appropriate corrections to the TLD response can be determined sufficiently well in order that the results of the specific radiation-hardness test can be determined within the required uncertainty.

7.5 The number of TLDs, or the number of replicates of measurements with a single TLD, used for each test should be sufficient to assure that the test results are significant at the 95 % confidence level. See Ref (3) for details of the procedures used to select random samples and to determine the sample size required.

NOTE 4—If a sample of *n* measurements Y_1, Y_2, \ldots, Y_n is taken, the best estimate of the population mean, *m*, of a normal distribution is given by the mean value, \bar{Y} , of the sample:

$$\bar{Y} = \frac{1}{n_{i=1}}^{n} Y_i \tag{5}$$

The best estimate of the variance, σ^2 , of the distribution is given by the variance, s^2 , of the sample:

$$s^{2} = \frac{1}{n-1} \sum_{i=1}^{n} \left(\bar{Y} - Y_{i} \right)^{2}$$
(6)

The quantity σ (= $\sqrt{s^2}$) is called the standard deviation of the distribution. The degree to which *s* is a best estimate of σ depends on the sample size and, as might be expected, *s* becomes a better estimate of σ as the sample size increases.

8. Specific Performance Tests and Correction Factors

8.1 Uniformity of TLD Response Within a Batch:

8.1.1 Select a random sample of 30 TLDs from a batch. Treating all of the sample TLDs in an identical manner, prepare them, irradiate them in the calibration facility to the same absorbed-dose level, and read them out. Determine the variance, s^2 , of the sample and estimate the standard deviation of the TLD response distribution ($\sigma = \sqrt{s^2}$). the standard deviation, σ , should not exceed 8 % of the sample mean value, \bar{Y}_0 ; that is, $\sigma \leq (0.08) \bar{Y}_0$. The sample size specified (30) is the number of measurements required to estimate the standard deviation, σ , of the TLD response distribution within 25 % of its true value at a 95 % confidence level (see 2.4 of Ref 3).

8.1.2 For reusable TLDs that have been subjected to a number of anneal-irradiation cycles, the uniformity of the batch response should be verified periodically by repeating the test in accordance with 8.1.1. The frequency required for the test depends on the type of TLD and on its previous anneal-irradiation history. Retesting of the batch uniformity becomes particularly important for TLDs irradiated to high-dose levels (>10² Gy (10⁴ rad)). See, however, X2.2.2.

8.2 Reproducibility of TLD Response of Individual Reusable Dosimeters—Certain types of TLDs may be utilized as individual reusable dosimeters. In this case, the identity of each individual dosimeter is maintained during repeated measurement cycles throughout its useful life. This is in contrast to utilization in the batch mode where individual dosimeters within the batch are not identified. To test the reproducibility of the response of an individual reusable dosimeter, the following procedures should be followed:

8.2.1 Select the individual TLD to be tested, prepare it, irradiate it in the calibration facility to a specific absorbed-dose level (for example, at the midpoint of the absorbed-dose range of interest), and read it out. In an identical manner, repeat this procedure 30 times. Determine the variance, s^2 , of the responses and estimate the standard deviation of the TLD response distribution ($\sigma = \sqrt{s^2}$). The standard deviation, σ , should not exceed 5 % of the mean response value, \bar{Y}_0 , that is $\sigma \leq (0.05) \bar{Y}_0$.

8.2.2 Some types of TLDs may exhibit a change in sensitivity (that is, response per unit absorbed dose) with repeated anneal-irradiation-readout cycling. This effect is most pronounced if the TLD is not annealed thoroughly. The test results in accordance with 8.2.1 may not show such a change in response sensitivity. However, if such a change is shown in that test or if it appears after a larger number of cycles than specified in that test, then a different analysis of the data is required. In this case, a curve should be fitted to the data of response versus number of cycles by a least-squares method. A measure of reproducibility would then be given by the average standard deviation of the data points from the least-squares curve. The performance criterion is the same as in 8.2.1.

8.2.3 Since the identity of each TLD is maintained when it is utilized as an individual dosimeter, it is not necessary that groups of such individual TLDs meet the batch requirements in accordance with 8.1. However, for the other performance tests and correction factors discussed in Section 8, it is assumed that such tests and factors are evaluated by utilizing TLDs in a batch mode.

8.3 Dependence of TLD Response on Absorbed-Dose Rate:

8.3.1 From a TLD batch meeting the requirements in accordance with 8.1.1, select a number of TLDs. Divide the TLDs into x number of groups, each group containing n samples. Determine the absorbed-dose-rate range of interest for the intended application and divide this range into x intervals (for example, one interval per decade). Prepare all the TLDs in an identical manner and irradiate each group to the same dose level, but at a different absorbed-dose-rate range of interest. Read out the TLDs. Determine the mean response, \bar{Y}_i , for each x group of n samples. Determine an overall mean value, \bar{Y}_0 , for all x group means. Then the absolute difference between any group mean and the overall mean should not exceed 20 % of the overall mean. That is,

$$|\bar{Y}_i - \bar{Y}_0| \le (0.2)\bar{Y}_0 \tag{7}$$

8.3.2 If $|\bar{Y}_i - \bar{Y}_0| > (0.05) \bar{Y}_0$, then appropriate correction factors to the TLD response as a function of absorbed-dose rate should be determined by the procedures that follow.

8.3.3 Determine the number of samples *n* required in each *x* group in order to detect a difference of $\delta = (0.05) \bar{Y}_0$ between a group mean and the overall mean for a confidence level of 95 % and a probability of 0.50 of failing to detect such a difference. It is assumed that the variance, σ^2 , of the TLD response determined in accordance with 8.1.1, does not vary with the absorbed-dose rate. Calculate the following parameter:

$$d = \frac{\delta}{\sqrt{2\sigma^2}} = \frac{\delta}{\sigma\sqrt{2}} \tag{8}$$

Then the sample size, n, is required for each x group to satisfy the above parameters is read off the graph of n versus d (see Fig. X3.1).

8.3.4 *Example of Sample Number Determination*—If $\sigma = 0.03 \ \bar{Y}_0$ (determined in 8.1.1),

$$d = \frac{0.05 \ \bar{Y}_0}{\sqrt{2} \ 0.03 \ \bar{Y}_0} = 1.18 \tag{9}$$

From Fig. X3.1, the sample size required is n = 4.4. The sample size should be 5, obtained by rounding up to the nearest integer.

NOTE 5—One method by which this test requirement can be carried out is by comparing the TLD responses with the response of another radiation dosimeter whose absorbed-dose-rate dependence is known. A suitable type of dosimeter for use in most cases would be calorimeter whose response is absorbed-dose-rate independent and whose radiation absorption properties are similar to the TLD under test.

8.4 Dependence of TLD Response on Energy:

8.4.1 The radiation absorption properties of the TLDs employed in radiation-hardness testing should be similar to those of the material in which the dose is to be estimated. Calculations can be made to determine the effects of a broad incident energy spectrum on the response of the TLDs compared to that of the material of interest (usually silicon). The requirements of 7.5 are not applicable to this section.

8.4.2 If the ratios $[(\mu_{en}/\rho)_{TLD}]/[(\mu_{en}/\rho)_{mat}]$ and $[(S/\rho)_{TLD}]/[(S/\rho)_{mat}]$ are equal to 1.0 within ± 10 % over a significant range of energy spectrum (for both calibration and test irradiations) incident upon both the TLD and the material of interest, then the energy-response performance of the TLD system is acceptable. Here, μ_{en}/ρ is the mass photon energy absorption coefficient and S/ρ is the mass collision electron stopping power. Tables of values of μ_{en}/ρ and S/ρ for several materials may be found in Appendix X4. The phrase "significant range of the energy limits containing those incident radiation particles (either photons or electrons) that contribute at least 90 % of the absorbed dose. In this case, detailed energy spectral information is not required; the incident particle fluence (either photons or electrons) between the energy limits is sufficient.

8.4.3 If the energy spectrum of the radiation incident upon the TLD (under both calibration and test conditions) and the material of interest (under test conditions) is well known, then the conversion from absorbed dose in the TLD to absorbed dose in the material of interest can be calculated from such data. If this conversion can be made to an uncertainty of ± 10 % or less, then the performance of the TLD system is acceptable. In this case, the criteria concerning the ratios of μ_{en}/ρ and S/ ρ in 8.4.2 need not be met. (See Practice E666 for more specific guidelines.)

8.5 Dependence of TLD Response on Direction of Incident Radiation:

8.5.1 If the geometrical orientation of the TLD with respect to the radiation-hardness test field is significantly different than its orientation with respect to the calibration radiation field, then any dependency of the TLD response on the direction of the incident radiation should be determined. Select a number of TLDs from a batch meeting the requirements in accordance with 8.1.1. Divide the TLDs into x number of groups, each group containing n samples. Prepare the TLDs in an identical manner, and irradiate each group to the same absorbed-dose level in the following manner: (a) group g_0 , in the usually oriented direction used for routine calibration, and (b) groups g_1, g_2, \ldots, g_x oriented, respectively, at angles $\theta_1, \theta_2, \ldots, \theta_x$ relative to the usually oriented direction with the center of the group at the same distance from the source. These angles should divide, in equal intervals of no more than 30° each, the angle between the normal and the maximum possible angle of incidence of the radiation-hardness test field. Read out all the TLDs. Determine the mean response, \bar{Y}_i , for each x group of n samples. Then the absolute difference between the mean, \bar{Y}_0 , for the normally used calibration orientation and the mean for any other orientation should not exceed 5 % of the mean \bar{Y}_0 . Thus:

$$|\bar{Y}_i - \bar{Y}_0| \le 0.05 \; \bar{Y}_0 \tag{10}$$

To determine the sample size n required for each x group, use the procedures in accordance with 8.3.3.

NOTE 6—This test applies only to a collimated-beam type source geometry. If the angle of incidence of the radiation from the source is nearly isotropic, then it is recommended that the TLDs and their encapsulation material should be as nearly spherical as possible.

8.6 Dependence of TLD Response on Time Between Preparation and Irradiation:

8.6.1 A change in TLD sensitivity can occur during the storage period between preparation and irradiation. This may be a significant effect if a wide range of storage periods is used. Use the following procedure to test for this effect. From a TLD batch meeting the requirements in accordance with 8.1.1, select two equal groups of n samples each. Prepare the first group of TLDs and place them in the storage facility for a time interval equal to the maximum time interval expected between preparation and irradiation during routine application in either calibration or hardness testing. At a later time, prepare the second group of TLDs, and place them in the storage facility for the minimum time interval expected between preparation and irradiation. Time the procedures so that the ends of the storage period for both groups occur simultaneously. Then irradiate both groups to the same absorbed-dose level in the calibration facility and read them all out. The difference between the mean TLD response, \bar{Y}_1 , of the first group and the mean response, \bar{Y}_2 , of the second group is a measure of the effect of storage time between preparation and irradiation. This difference should not exceed 20 % of the average of the means of the two groups. Thus:

$$|\bar{Y}_1 - \bar{Y}_2| \le (0.2) \frac{\bar{Y}_1 + \bar{Y}_2}{2} - 6668 - 05$$
(11)

8.6.2 If the effect tested for in accordance with 8.6.1 exceeds 5 % of the average of the group means, then the functional dependence of the TLD response on the storage period should be determined in order that appropriate correction factors may be applied. This functional dependence may be determined by the procedures that follow.

8.6.3 The range of the elapsed time intervals between preparation and irradiation of interest is determined from the minimum and maximum intervals utilized in 8.6.1. Tests should be performed at a minimum of two intervals per decade of elapsed time over the entire range. For example, if the minimum elapsed time is 0.1 h and maximum elapsed time is 100 h, then an appropriate set of tests would be at elapsed times of 0.1, 0.3, 1, 3, 10, 30, and 100 h. From a TLD batch meeting the requirements in accordance with 8.1.1, select as many groups of *n* samples each as there are elapsed time intervals as determined above. Prepare a group of TLDs, and place it in the storage facility for the appropriate preselected test-time interval. Repeat this procedure for all preselected storage time intervals from the maximum to the minimum elapsed time. Arrange the storage times so that the ends of all procedures occur simultaneously. Then irradiate all groups to the same dose level in the calibration facility and read them all out as quickly as possible thereafter. This procedure is designed to minimize effects on dosimeter response caused by fading and variation in reader output. Determine the mean response for each group of TLDs. A plot of mean TLD response versus elapsed time provides a correction factor for a change in TLD sensitivity as a function of storage period. The number of samples n required for each group of TLDs should be determined by the procedure in accordance with 8.3.3.

8.7 Dependence of TLD Response on Time Between Irradiation and Readout:

8.7.1 Significant fading of the TLD response may occur during the storage period between the end of irradiation and readout. Use the following procedure to test for this effect. From a TLD batch meeting the requirements in accordance with 8.1.1, select two equal groups of *n* samples each. Prepare the first group of TLDs, irradiate them in the calibration facility to a specific dose level, then place them in the storage facility for an interval equal to the maximum time interval expected during routine application (for either calibration or hardness testing) between the end of the irradiation period and readout. Prepare the second group of TLDs, irradiate them in the calibration facility to the same dose level as the first group, then place them in the storage facility for an interval equal to the minimum time interval expected between the end of irradiation and readout. Time the procedures so the ends of the storage periods for both groups occur simultaneously. Read out all of the TLDs. The absolute difference between the mean TLD response, \bar{Y}_1 , of the first group and the mean response, \bar{Y}_2 , of the second group is a measure of the effect of storage time between the end of irradiation and readout. The difference should not exceed 20 % of the average of the means of the two groups. Thus:

$$|\bar{Y}_1 - \bar{Y}_2| (\le 0.2) \frac{\bar{Y}_1 + \bar{Y}_2}{2} \frac{ASTM}{2}$$

8.7.2 If the fading effect is greater than $(0.05)(\bar{Y}_1 + \bar{Y}_2)/2$, then either a correction should be made to the TLD response or a procedure used that eliminates the need for a correction. A procedure that achieves the latter would be one in which all TLDs are read out at the same elapsed time after the end or irradiation. Such a procedure is often inconvenient or impractical. Therefore, it is usually necessary to apply a fading correction to the TLD response. The fading characteristics of the TLD system may be determined by the test procedures that follow.

8.7.3 Determine the minimum and maximum elapsed times between the end of the irradiation period and readout. Tests should be performed at a minimum of two time intervals per decade of elapsed time over the entire period in accordance with 8.6.3. From a TLD batch meeting the requirements in accordance with 8.1.1, select as many groups of n samples each as there are elapsed time intervals as determined above. Each group of TLDs should undergo identical preparation and then should be irradiated in the calibration facility to the same dose level. The groups of TLDs are placed in the storage facility for all preselected appropriate time intervals from the maximum to the minimum elapsed time. Arrange the time of irradiations for all the groups so that the ends of their storage periods occur simultaneously. Read out all the TLDs. Determine the mean response for each group of TLDs. A plot of mean TLD response versus elapsed time provides the fading correction factor. The number of samples n required for each group of TLDs should be determined by the procedures in accordance with 8.3.3.

8.8 Dependence of TLD Response on Temperature During Storage or Irradiation:

8.8.1 If the storage temperature experienced by the TLDs between preparation and irradiation during routine radiation-hardness testing differs from the temperature during routine calibration by more than 10°C, the test in accordance with 8.6 should be repeated over the range of temperatures expected using the environmental chamber instead of the storage facility. The performance criteria in accordance with 8.6 are applicable to this section.

8.8.2 If the storage temperature experienced by the TLDs between irradiation and readout during routine radiationhardness testing differs from the temperature during routine calibration by more than 10°C, the test in accordance with 8.7 should be repeated over the range of temperatures expected using the environmental chamber instead of the storage facility. The performance criteria in accordance with 8.7 are applicable to this section.

8.8.3 If the temperature experienced by the TLDs during the irradiation period during routine radiation-hardness testing differs from the temperature during routine calibration by more than 10°C, then the effect on TLD response should be determined by the following procedure: Select a number of TLDs from a batch meeting the requirements in accordance with 8.1.1, prepare them in an identical manner, and separate them into two equal groups of n samples each. Irradiate the first group in the calibration facility to a specific dose level, maintaining the temperature of the TLDs at the minimum temperature expected during routine hardness-test irradiation. Irradiate the second group in the calibration facility to the same dose level, maintaining the temperature of the TLDs at the maximum temperature expected during routine hardness-test irradiations. Readout all of the TLDs. The difference between the mean TLD response, \bar{Y}_1 , of the first group and the mean response, \bar{Y}_2 , of the second group is a measure of the effect of temperature variation during irradiation. This difference should not exceed 20 % of the average of the means of the two groups. If the magnitude of the effect is greater than 5 % of the average of the means, then appropriate corrections to the TLD responses should be determined by procedures analogous to those in accordance with 8.6.

8.9 Dependence of TLD Response on Humidity—In general, the responses of the most widely used TLDs have not been shown to be sensitive to changes in relative humidity. However, if a TLD that is hygroscopic is being considered for application in radiation-hardness testing, then the performance tests in accordance with 8.8 should be repeated with the humidity as the variable parameter and the temperature maintained at the maximum value used in the temperature tests.

NOTE 7—Once a TLD system of a particular TL-phosphor type and physical configuration has met the performance requirements of Section 8, new batches of the same type need only be tested for the requirements of